

Search Notes

Application/Control No.

10/768,507

Examiner

John J. Figueroa

Applicant(s)/Patent under
Reexamination

MAIER ET AL.

Art Unit

1712

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC (Chemical Structure Search)	8/14/2007	JJF
NPL (Non-Patent Literature Searched on STIC and on internet)	8/14/2007	JJF